











**CSD18537NKCS** 

SLPS390A -JUNE 2013-REVISED MARCH 2015

# CSD18537NKCS 60 V N-Channel NexFET™ Power MOSFET

#### **Features**

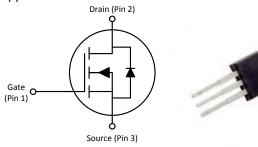
- Ultra Low Qa and Qad
- Low Thermal Resistance
- Avalanche Rated
- Pb Free Terminal Plating
- **RoHS Compliant**
- Halogen Free
- TO-220 Plastic Package

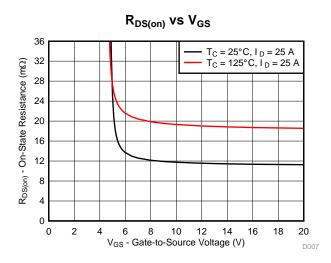
# Applications

- High Side Synchronous Buck Converter
- Motor Control

### **Description**

This 11 mΩ, 60 V TO-220 NexFET™ power MOSFET is designed to minimize losses in power conversion applications.





#### **Product Summary**

| T <sub>A</sub> = 25° | С                             | TYPICAL VA                | UNIT |    |  |  |  |
|----------------------|-------------------------------|---------------------------|------|----|--|--|--|
| $V_{DS}$             | Drain-to-Source Voltage 60    |                           |      |    |  |  |  |
| $Q_g$                | Gate Charge Total (10 V)      | Charge Total (10 V) 14    |      |    |  |  |  |
| Q <sub>gd</sub>      | Gate Charge Gate-to-Drain     | 2.3                       | nC   |    |  |  |  |
| 0                    | Drain-to-Source On-Resistance | V <sub>GS</sub> = 6 V     | 14   | mΩ |  |  |  |
| R <sub>DS(on)</sub>  | Diam-to-Source On-Resistance  | V <sub>GS</sub> = 10 V 11 |      | mΩ |  |  |  |
| V <sub>GS(th)</sub>  | Threshold Voltage             | 3                         |      | V  |  |  |  |

#### Ordering Information(1)

|              | _                      |       |     |      |
|--------------|------------------------|-------|-----|------|
| Device       | Package                | Media | Qty | Ship |
| CSD18537NKCS | TO-220 Plastic Package | Tube  | 50  | Tube |

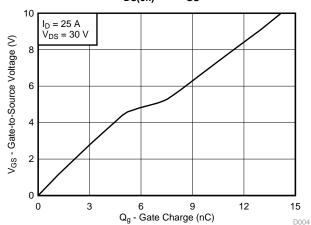
(1) For all available packages, see the orderable addendum at the end of the data sheet.

## **Absolute Maximum Ratings**

|                                      | Absolute Maximum Ratings   |            |      |  |  |  |  |  |  |  |
|--------------------------------------|--|------------|------|--|--|--|--|--|--|--|
| T <sub>A</sub> = 2                   | 5°C  | VALUE      | UNIT |  |  |  |  |  |  |  |
| $V_{DS}$                             | Drain-to-Source Voltage  | 60         | V    |  |  |  |  |  |  |  |
| $V_{GS}$                             | Gate-to-Source Voltage   | ±20        | V    |  |  |  |  |  |  |  |
|                                      | Continuous Drain Current (Package limited)                         | 50         |      |  |  |  |  |  |  |  |
| I <sub>D</sub>                       | Continuous Drain Current (Silicon limited), $T_C = 25^{\circ}C$    | 56         | Α    |  |  |  |  |  |  |  |
|                                      | Continuous Drain Current (Silicon limited), $T_C = 100$ °C         | 39         |      |  |  |  |  |  |  |  |
| $I_{DM}$                             | Pulsed Drain Current (1)   | 127        | Α    |  |  |  |  |  |  |  |
| $P_D$                                | Power Dissipation  | 94         | W    |  |  |  |  |  |  |  |
| T <sub>J</sub> ,<br>T <sub>stg</sub> | Operating Junction and<br>Storage Temperature Range                | -55 to 175 | °C   |  |  |  |  |  |  |  |
| E <sub>AS</sub>                      | Avalanche Energy, single pulse $I_D=33~A,~L=0.1~mH,~R_G=25~\Omega$ | 55         | mJ   |  |  |  |  |  |  |  |

(1) Max  $R_{\theta JC} = 1.6^{\circ}C/W$ , pulse duration  $\leq 100 \ \mu s$ , duty cycle  $\leq 1\%$ 

#### R<sub>DS(on)</sub> vs V<sub>GS</sub>





# **Table of Contents**

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# 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| C | changes from Original (June 2013) to Revision A                                  | Page         |
|---|--|--------------|
| • | Added part number to title   | 1            |
| • | Increased the T <sub>C</sub> = 25° continuous drain current to 56 A              | 1            |
| • | Increased the T <sub>C</sub> = 125° continuous drain current to 39 A             | 1            |
| • | Increased the pulsed drain current to 127 A                                      | 1            |
| • | Increased the max power dissipation to 94 W                                      | 1            |
| • | Increased the max operating junction and storage temperature to 1750             | 1            |
| • | Updated the pulsed current conditions  | 1            |
|   | Updated Figure 1 from a normalized R <sub>BJA</sub> to an R <sub>BJC</sub> curve |              |
| • | Updated Figure 6 to extend to 175°C  | <del>5</del> |
| • | Updated Figure 8 to extend to 175°C  | <del>5</del> |
| • |  |              |
| • | Updated Figure 12 to extend to 175°C   | 6            |



# 5 Specifications

## 5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

|                     | PARAMETER                        | TEST CONDITIONS  | MIN TYP | MAX  | UNIT |
|---------------------|----------------------------------|--|---------|------|------|
| STATIC              | CHARACTERISTICS                  |  |         |      |      |
| BV <sub>DSS</sub>   | Drain-to-Source Voltage          | V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA                   | 60      |      | V    |
| I <sub>DSS</sub>    | Drain-to-Source Leakage Current  | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 48 V                    |         | 1    | μΑ   |
| I <sub>GSS</sub>    | Gate-to-Source Leakage Current   | V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V                    |         | 100  | nA   |
| V <sub>GS(th)</sub> | Gate-to-Source Threshold Voltage | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA      | 2.6 3   | 3.5  | V    |
| <u></u>             | Designate Course On Registeres   | V <sub>GS</sub> = 6 V, I <sub>D</sub> = 25 A                     | 14      | 18   | mΩ   |
| R <sub>DS(on)</sub> | Drain-to-Source On-Resistance    | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 25 A                    | 11      | 14   | mΩ   |
| $g_{fs}$            | Transconductance                 | V <sub>DS</sub> = 30 V, I <sub>D</sub> = 25 A                    | 100     |      | S    |
| DYNAM               | IC CHARACTERISTICS               |  |         |      |      |
| C <sub>iss</sub>    | Input Capacitance                |  | 1140    | 1480 | pF   |
| C <sub>oss</sub>    | Output Capacitance               | $V_{GS} = 0 \text{ V}, V_{DS} = 30 \text{ V}, f = 1 \text{ MHz}$ | 136     | 177  | pF   |
| C <sub>rss</sub>    | Reverse Transfer Capacitance     |  | 4.0     | 5.2  | pF   |
| $R_G$               | Series Gate Resistance           |  | 5.5     | 11   | Ω    |
| Qg                  | Gate Charge Total (10 V)         |  | 14      | 18   | nC   |
| Q <sub>gd</sub>     | Gate Charge Gate-to-Drain        | V 00 V 1 05 A  | 2.3     |      | nC   |
| Q <sub>gs</sub>     | Gate Charge Gate-to-Source       | $V_{DS} = 30 \text{ V}, I_{D} = 25 \text{ A}$                    | 5.2     |      | nC   |
| Q <sub>g(th)</sub>  | Gate Charge at V <sub>th</sub>   |  | 3.3     |      | nC   |
| Q <sub>oss</sub>    | Output Charge                    | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V                    | 25      |      | nC   |
| t <sub>d(on)</sub>  | Turn On Delay Time               |  | 4.5     |      | ns   |
| t <sub>r</sub>      | Rise Time                        | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 10V,                   | 3.2     |      | ns   |
| t <sub>d(off)</sub> | Turn Off Delay Time              | $I_{DS} = 25 \text{ A}, R_G = 0 \Omega$                          | 12.6    |      | ns   |
| $t_f$               | Fall Time                        |  | 3.9     |      | ns   |
| DIODE (             | CHARACTERISTICS                  |  | ı       |      |      |
| $V_{SD}$            | Diode Forward Voltage            | I <sub>SD</sub> = 25 A, V <sub>GS</sub> = 0 V                    | 0.9     | 1    | V    |
| Q <sub>rr</sub>     | Reverse Recovery Charge          | V <sub>DS</sub> = 30 V, I <sub>F</sub> = 25 A,                   | 77      |      | nC   |
| t <sub>rr</sub>     | Reverse Recovery Time            | di/dt = 300 A/µs   | 50      |      | ns   |

#### 5.2 Thermal Information

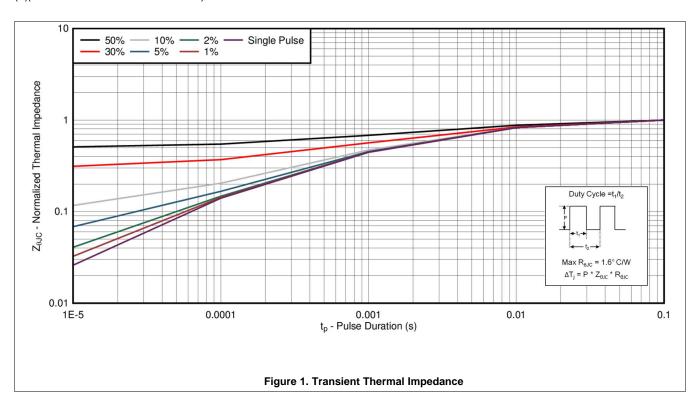
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

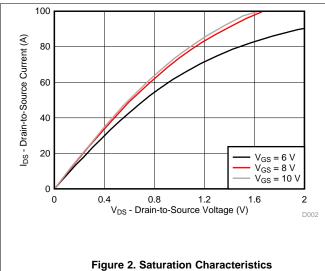
|                 | THERMAL METRIC                         | MIN | TYP | MAX | UNIT |
|-----------------|--|-----|-----|-----|------|
| $R_{\theta JC}$ | Junction-to-Case Thermal Resistance    |     |     | 1.6 | °C/W |
| $R_{\theta JA}$ | Junction-to-Ambient Thermal Resistance |     |     | 62  | C/VV |

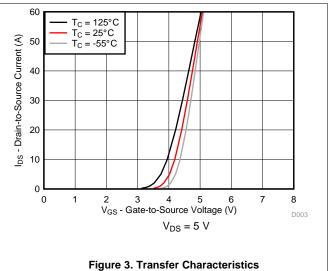
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# 5.3 Typical MOSFET Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 







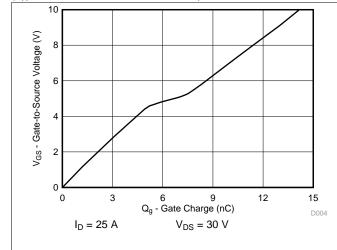
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## **Typical MOSFET Characteristics (continued)**

(T<sub>A</sub> = 25°C unless otherwise stated)



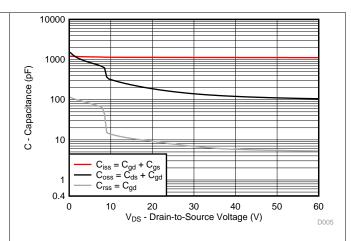


Figure 4. Gate Charge

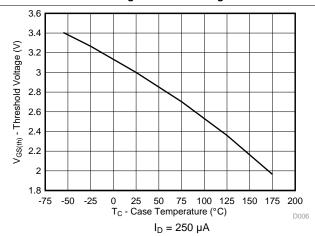


Figure 5. Capacitance

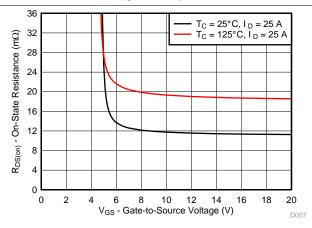


Figure 6. Threshold Voltage vs Temperature

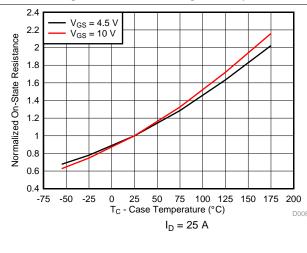


Figure 7. On-State Resistance vs Gate-to-Source Voltage

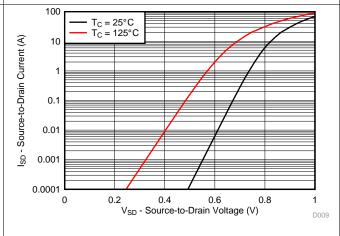


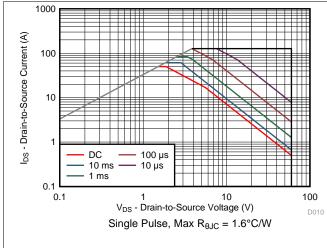
Figure 8. Normalized On-State Resistance vs Temperature

Figure 9. Typical Diode Forward Voltage



## **Typical MOSFET Characteristics (continued)**

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 



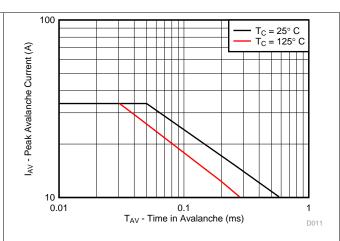


Figure 10. Maximum Safe Operating Area (SOA)

Figure 11. Single Pulse Unclamped Inductive Switching

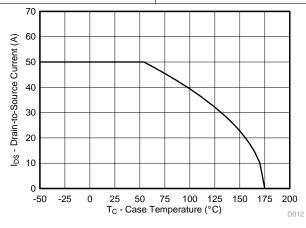


Figure 12. Maximum Drain Current vs Temperature



# 6 Device and Documentation Support

#### 6.1 Trademarks

NexFET is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

### 6.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 6.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

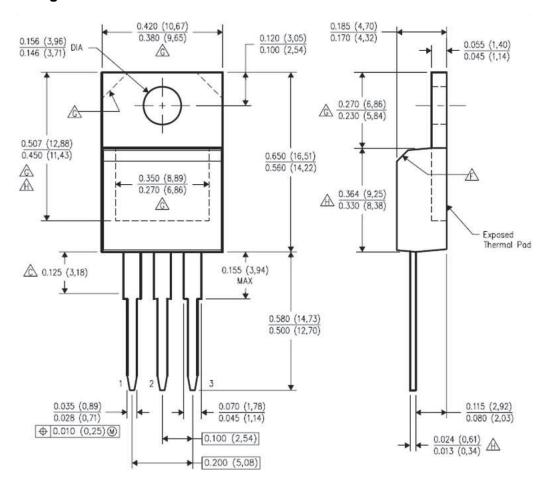
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## 7 Mechanical Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

#### 7.1 KCS Package Dimensions



#### Notes:

- 1. All linear dimensions are in inches
- 2. This drawing is subject to change without notice
- 3. Lead Dimensions are not controlled within "C" area
- 4. All lead dimensions apply before solder dip
- 5. The center lead is in electrical contact with the mounting tab
- 6. The chamfer at "F" is optional
- 7. Thermal pad contour at "G" optional with these dimensions
- 8. "H" Falls within JEDEC TO-220 variation AB, except minimum lead thickness, minimum exposed pad length, and maximum body length.

**Pin Configuration** 

|             | 0           |
|-------------|-------------|
| Position    | Designation |
| Pin 1       | Gate        |
| Pin 2 / Tab | Drain       |
| Pin 3       | Source      |



## PACKAGE OPTION ADDENDUM

30-Apr-2016

#### PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan          | Lead/Ball Finish (6) | MSL Peak Temp      | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|--------|--------------|--------------------|------|----------------|-------------------|----------------------|--------------------|--------------|----------------------|---------|
| CSD18537NKCS     | ACTIVE | TO-220       | KCS                | 3    | 50             | Pb-Free<br>(RoHS) | CU SN                | N / A for Pkg Type | -55 to 150   | 18537N               | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### Products Applications

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